Substitute Form P 0-1449 (Modified)

. Department of Commerce atent and Trademark Office

Attorney's Docket No. 12900-001001 Application No. 09/845,178

by Applicant

by Applicant
(Use several sheets if necessary)

Zhonghua Lu et al.

Filing Date April 27, 2001

Applicant

Group Art Unit 1746

(37 CFR §1.98(b))

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Substitute Disclosure Form (PTO-1449)

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